

## MOSFET – Power, Single N-Channel, μ8FL 30 V, 3.6 m $\Omega$ , 102 A

### **NVTFS4C05N**

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C05NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter Symbol Value Unit						
Paran	Symbol	Value	Unit			
Drain-to-Source Voltage	$V_{DSS}$	30	V			
Gate-to-Source Voltage			$V_{GS}$	±20	٧	
Continuous Drain Current R <sub>θJA</sub>		T <sub>A</sub> = 25°C	I <sub>D</sub>	22	Α	
(Notes 1, 2, 4)		T <sub>A</sub> = 100°C		15.7		
Power Dissipation R <sub>θJA</sub>		T <sub>A</sub> = 25°C	$P_{D}$	3.2	W	
(Notes 1, 2, 4)	Steady	T <sub>A</sub> = 100°C		1.6		
Continuous Drain Current R <sub>ψJC</sub>	State	T <sub>C</sub> = 25°C	I <sub>D</sub>	102	Α	
(Notes 1, 3, 4)		T <sub>C</sub> = 100°C		72		
Power Dissipation		T <sub>C</sub> = 25°C	$P_{D}$	68	W	
$R_{\psi JC}$ (Notes 1, 3, 4)		T <sub>C</sub> = 100°C		34		
Pulsed Drain Current	T <sub>A</sub> = 25°	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	433	Α	
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C	
Source Current (Body Die	I <sub>S</sub>	65	Α			
Single Pulse Drain-to-So (T <sub>J</sub> = 25°C, V <sub>GS</sub> = 10 V, I	E <sub>AS</sub>	88	mJ			
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

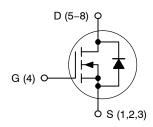
#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Notes 1, 3)	$R_{\psi JC}$	2.2	°C/W
Junction-to-Ambient – Steady State (Notes 1, 2)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.
- 2. Surface-mounted on FR4 board using 650 mm<sup>2</sup>, 2 oz. Cu Pad.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- Continuous DC current rating. Maximum current for pulses as long as one second is higher but dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX		
30 V	3.6 m $\Omega$ @ 10 V	102 A		
30 V	5.1 mΩ @ 4.5 V	102 A		

#### **N-Channel MOSFET**



#### WDFN8 (μ8FL) CASE 511AB

# MARKING DIAGRAM 1 S (O) S (XXXX) D S (AYWW) D G ( D) D

4C05 = Specific Device Code for

NVMTS4C05N

05WF = Specific Device Code of

NVTFS4C05NWF

A = Assembly Location

Y = Year WW = Work Week

■ = Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

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#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			<u> </u>	-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				11.7		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	1 ,
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.3		2.2	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		2.9	3.6	0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		4.1	5.1	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>E</sub>	<sub>0</sub> = 15 A		68		S
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°	С		1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1988		
Output Capacitance	Coss	V <sub>GS</sub> = 0 V, f = 1 MH		1224		pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>			71			
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz			0.036		
Total Gate Charge	Q <sub>G(TOT)</sub>				14.5		20
Threshold Gate Charge	Q <sub>G(TH)</sub>	1			2.9		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			5.2		nC
Gate-to-Drain Charge	$Q_{GD}$				5.5		
Gate Plateau Voltage	V <sub>GP</sub>				3.1		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 1	5 V; I <sub>D</sub> = 30 A		31		nC
SWITCHING CHARACTERISTICS (Note 6	)						
Turn-On Delay Time	t <sub>d(ON)</sub>				11		
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS}$	<sub>S</sub> = 15 V,		30		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS}$ $I_{D} = 15 \text{ A}, R_{G}$	= 3.0 Ω		20		
Fall Time	t <sub>f</sub>				8.0		
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,			8.0		
Rise Time	t <sub>r</sub>				25		- ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	I <sub>D</sub> = 15 A, R <sub>G</sub>		26			
Fall Time	t <sub>f</sub>			5.0			
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.77	1.1	1 V
		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.62		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			42.4		ns
Charge Time	ta				21.1		
Discharge Time	t <sub>b</sub>				21.3		
Reverse Recovery Charge	Q <sub>RR</sub>				34.4		nC

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

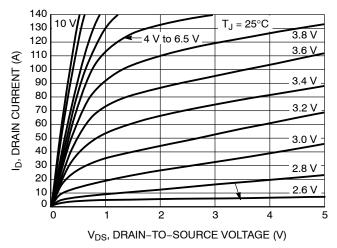


Figure 1. On-Region Characteristics

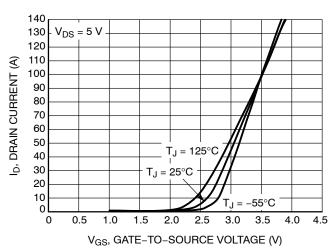


Figure 2. Transfer Characteristics

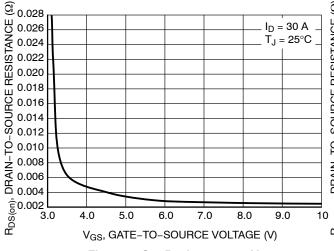


Figure 3. On-Resistance vs. V<sub>GS</sub>

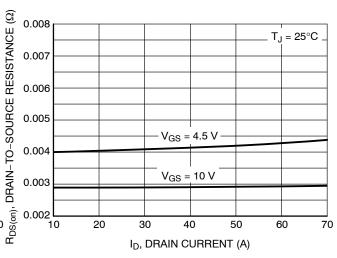


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

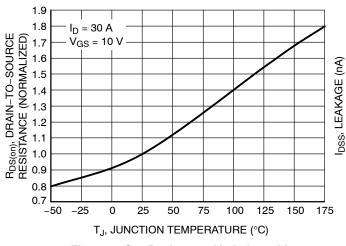


Figure 5. On–Resistance Variation with Temperature

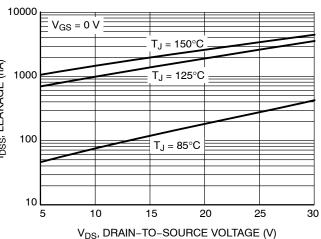


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

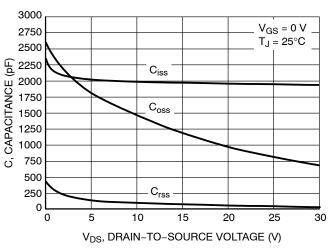


Figure 7. Capacitance Variation

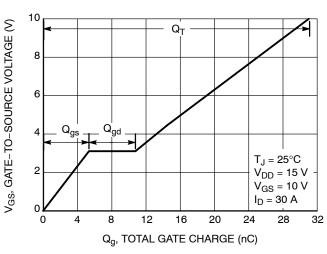


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

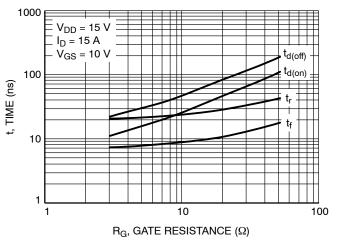


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

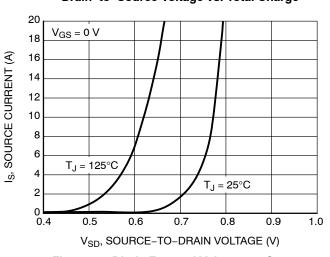


Figure 10. Diode Forward Voltage vs. Current

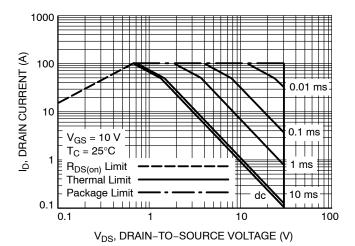


Figure 11. Maximum Rated Forward Biased Safe Operating Area

#### **TYPICAL CHARACTERISTICS**

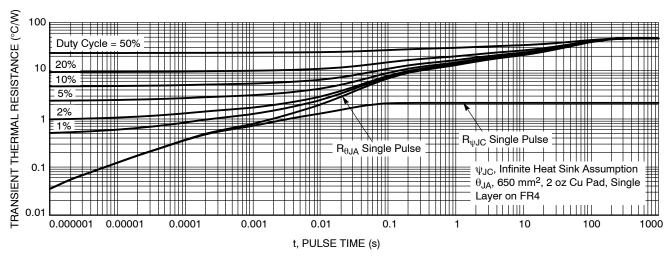


Figure 12. Thermal Response

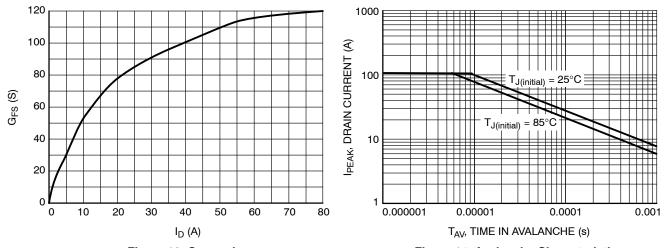


Figure 13.  $G_{FS}$  vs.  $I_D$ 

Figure 14. Avalanche Characteristics

#### **ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS4C05NTAG	4C05	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C305NETAG-YE	4C05	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C05NWFTAG	05WF	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C305NETAG	4C05	WDFN8 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

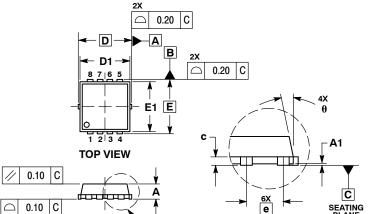




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#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

**DATE 23 APR 2012** 



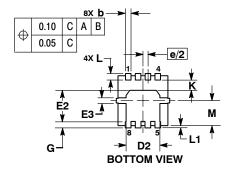
**DETAIL A** 

**DETAIL A** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E	3.30 BSC			0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



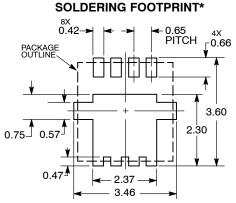
#### **GENERIC MARKING DIAGRAM\***

**SIDE VIEW** 



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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